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## LED ARRAY



Lead-Free Parts

## LA16B/HRF-S30-PF

## DATA SHEET

DOC. NO : QW0905-LA16B/HRF-S30-PF

REV. : A

DATE : 20 - Jun. - 2006



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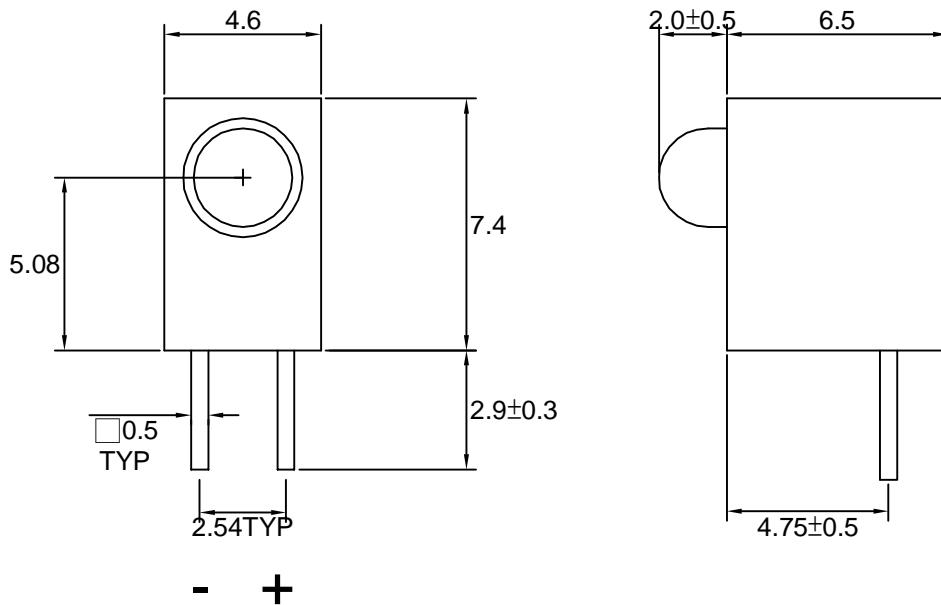
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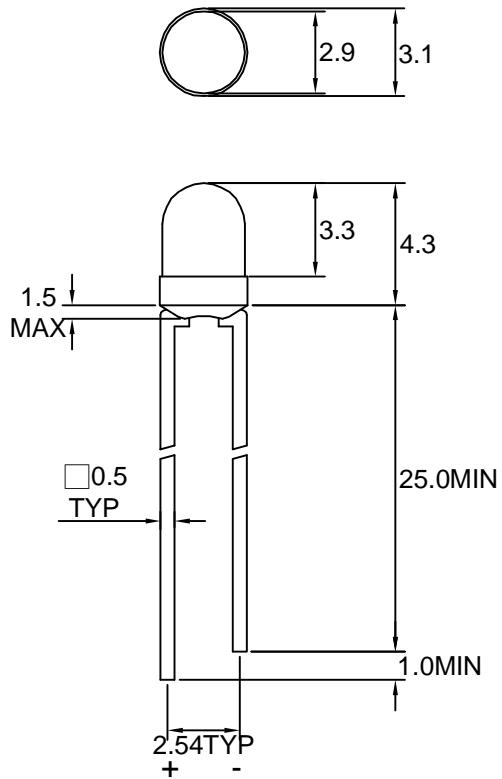
PART NO. LA16B/HRF-S30-PF

Page 1/5

### Package Dimensions



LHRF2643-1-PF



Note : 1. All dimension are in millimeter tolerance is  $\pm 0.25\text{mm}$  unless otherwise noted.  
2. Specifications are subject to change without notice.



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PART NO. LA16B/HRF-S30-PF

Page 2/5

## Absolute Maximum Ratings at Ta=25 °C

Parameter	Symbol	Ratings		UNIT
		HRF		
Forward Current	I <sub>F</sub>	30		mA
Peak Forward Current Duty 1/10@10KHz	I <sub>FP</sub>	90		mA
Power Dissipation	P <sub>D</sub>	75		mW
Reverse Current @5V	I <sub>r</sub>	10		μA
Electrostatic Discharge( * )	ESD	2000		V
Operating Temperature	T <sub>opr</sub>	-40 ~ +85		°C
Storage Temperature	T <sub>stg</sub>	-40 ~ +100		°C

\* Static Electricity or power surge will damage the LED. Use of a conductive wrist band or anti-electrosatic glove is recommended when handing these LED. All devices, equipment and machinery must be properly grounded.

## Typical Electrical &amp; Optical Characteristics (Ta=25 °C)

PART NO	MATERIAL	COLOR		Dominant wave length λ Dnm	Spectral halfwidth △ λ nm	Forward voltage @20mA(V)		Luminous intensity @20mA(mcd)		Viewing angle 2θ 1/2 (deg)
		Emitted	Lens			Min.	Max.	Min.	Typ.	
LA16B/HRF-S30-PF	AlGaInP	Red	Water Clear	630	20	1.5	2.4	450	700	40

Note : 1.The forward voltage data did not including ±0.1V testing tolerance.

2. The luminous intensity data did not including ±15% testing tolerance.



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PART NO. LA16B/HRF-S30-PF

Page 3/5

## Typical Electro-Optical Characteristics Curve

### HRF CHIP

Fig.1 Forward current vs. Forward Voltage

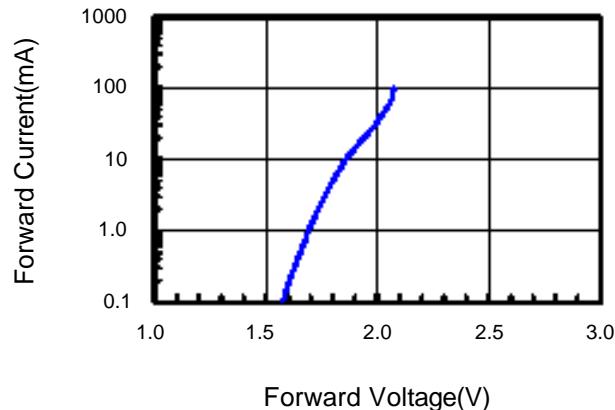


Fig.3 Forward Voltage vs. Temperature

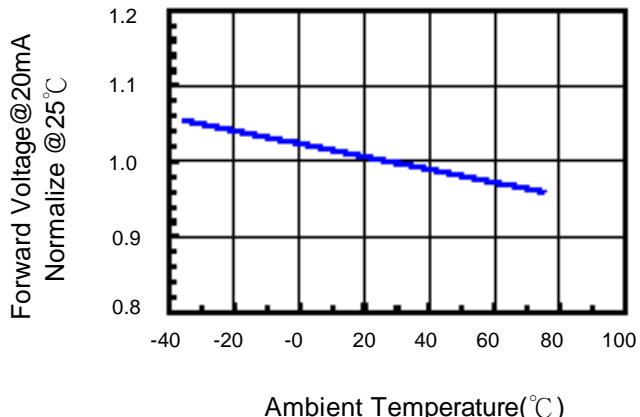


Fig.5 Relative Intensity vs. Wavelength

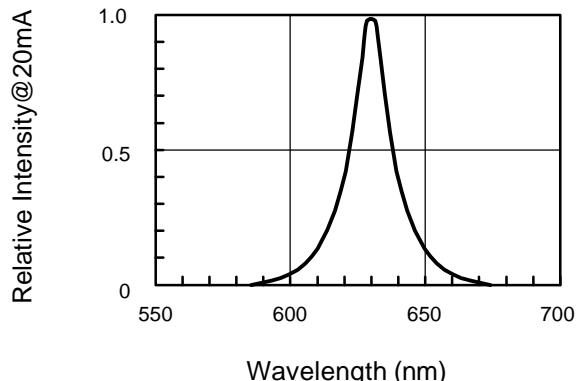


Fig.2 Relative Intensity vs. Forward Current

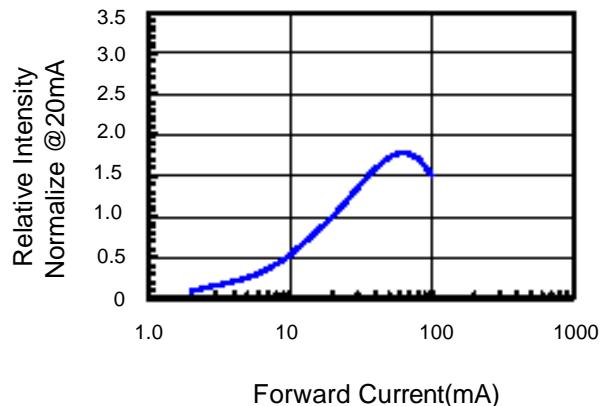
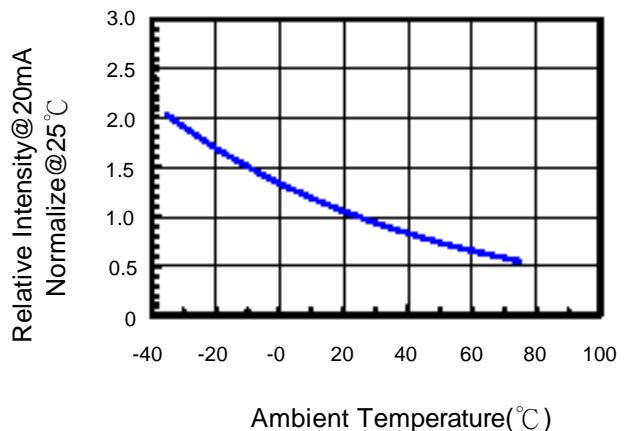


Fig.4 Relative Intensity vs. Temperature





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PART NO. LA16B/HRF-S30-PF

Page 4/5

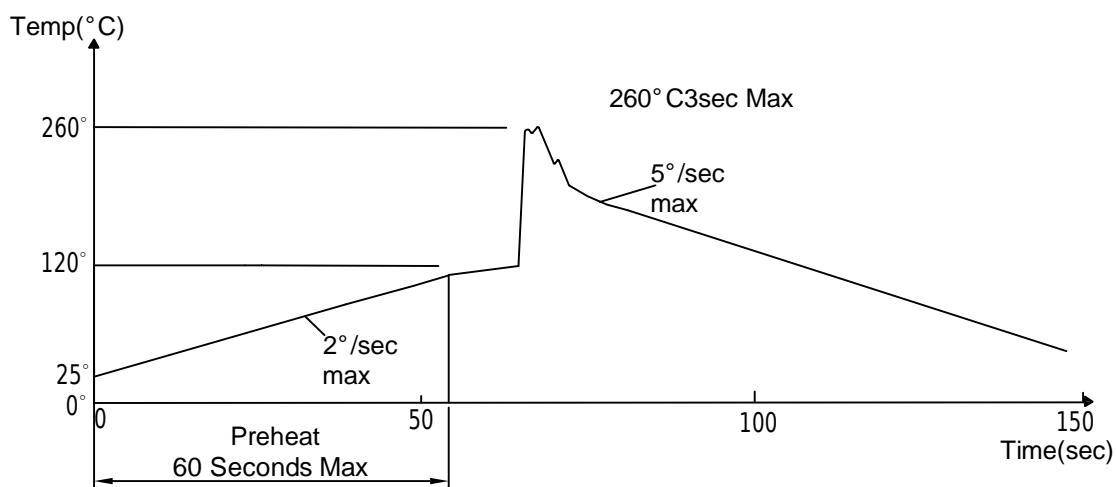
## Soldering Condition(Pb-Free)

### 1.Iron:

Soldering Iron:30W Max  
Temperature 350°C Max  
Soldering Time:3 Seconds Max(One Time)  
Distance:2mm Min(From solder joint to case)

### 2.Wave Soldering Profile

Dip Soldering  
Preheat: 120°C Max  
Preheat time: 60seconds Max  
Ramp-up  
2°C/sec(max)  
Ramp-Down:-5°C/sec(max)  
Solder Bath:260°C Max  
Dipping Time:3 seconds Max  
Distance:2mm Min(From solder joint to case)





PART NO. LA16B/HRF-S30-PF

Page 5/5

**Reliability Test:**

Test Item	Test Condition	Description	Reference Standard
Operating Life Test	1.Under Room Temperature 2.If=20mA 3.t=1000 hrs (-24hrs, +72hrs)	This test is conducted for the purpose of determining the resistance of a part in electrical and thermal stressed.	MIL-STD-750: 1026 MIL-STD-883: 1005 JIS C 7021: B-1
High Temperature Storage Test	1.Ta=105 °C±5°C 2.t=1000 hrs (-24hrs, +72hrs)	The purpose of this is the resistance of the device which is laid under condition of high temperature for hours.	MIL-STD-883:1008 JIS C 7021: B-10
Low Temperature Storage Test	1.Ta=-40 °C±5°C 2.t=1000 hrs (-24hrs, +72hrs)	The purpose of this is the resistance of the device which is laid under condition of low temperature for hours.	JIS C 7021: B-12
High Temperature High Humidity Test	1.Ta=65 °C±5°C 2.RH=90 %~95% 3.t=240hrs ±2hrs	The purpose of this test is the resistance of the device under tropical for hours.	MIL-STD-202:103B JIS C 7021: B-11
Thermal Shock Test	1.Ta=105 °C±5°C &-40°C±5°C (10min) (10min) 2.total 10 cycles	The purpose of this is the resistance of the device to sudden extreme changes in high and low temperature.	MIL-STD-202: 107D MIL-STD-750: 1051 MIL-STD-883: 1011
Solder Resistance Test	1.T.Sol=260 °C±5°C 2.Dwell time= 10 ±1sec.	This test intended to determine the thermal characteristic resistance of the device to sudden exposures at extreme changes in temperature when soldering the lead wire.	MIL-STD-202: 210A MIL-STD-750: 2031 JIS C 7021: A-1
Solderability Test	1.T.Sol=230 °C±5°C 2.Dwell time=5 ±1sec	This test intended to see soldering well performed or not.	MIL-STD-202: 208D MIL-STD-750: 2026 MIL-STD-883: 2003 JIS C 7021: A-2